

P-Channel 150-V (D-S) MOSFET

PRODUCT SUMMARY

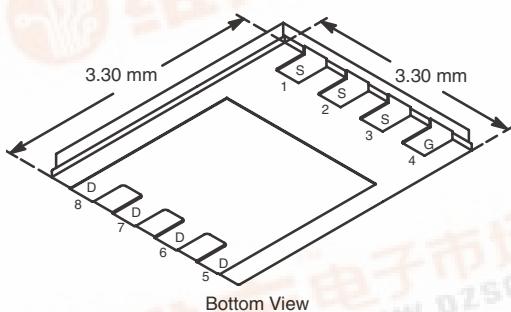
V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)	Q_g (Typ.)
- 150	0.295 at $V_{GS} = -10$ V	- 8.9 ^e	23.2 nC
	0.315 at $V_{GS} = -6.0$ V	- 8.6 ^e	

FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET
- Low Thermal Resistance PowerPAK® Package with Small Size and Low 1.07 mm Profile
- UIS and R_g tested



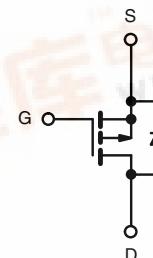
PowerPAK 1212-8



Ordering Information: Si7115DN-T1-E3 (Lead (Pb)-free)
Si7115DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- Active Clamp in Intermediate DC/DC Power Supplies
- H-Bridge High Side Switch for Lighting Application



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 150	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 150$ °C)	$T_C = 25$ °C	I_D	A
	$T_C = 70$ °C		
	$T_A = 25$ °C		
	$T_A = 70$ °C		
Pulsed Drain Current	I_{DM}	- 15	
Continuous Source-Drain Diode Current	$T_C = 25$ °C	I_S	mJ
	$T_A = 25$ °C		
Avalanche Current	I_{AS}	15	
Single-Pulse Avalanche Energy	E_{AS}	11.25	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	W
	$T_C = 70$ °C		
	$T_A = 25$ °C		
	$T_A = 70$ °C		
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 50 to 150	
Soldering Recommendations (Peak Temperature) ^{c, d}		260	°C

Notes:

- Surface Mounted on 1" x 1" FR4 board.
- $t = 10$ s.
- See Solder Profile (www.vishay.com/ppg?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Based on $T_C = 25$ °C.

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	$t \leq 10 \text{ s}$	R_{thJA}	26	33	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	1.9	2.4	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
b. Maximum under Steady State conditions is 81 °C/W.

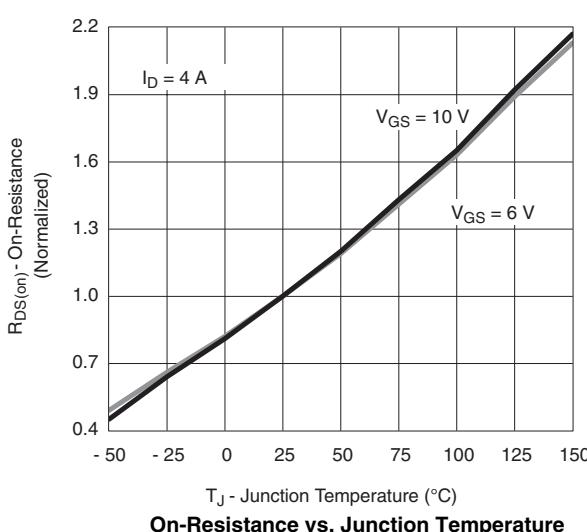
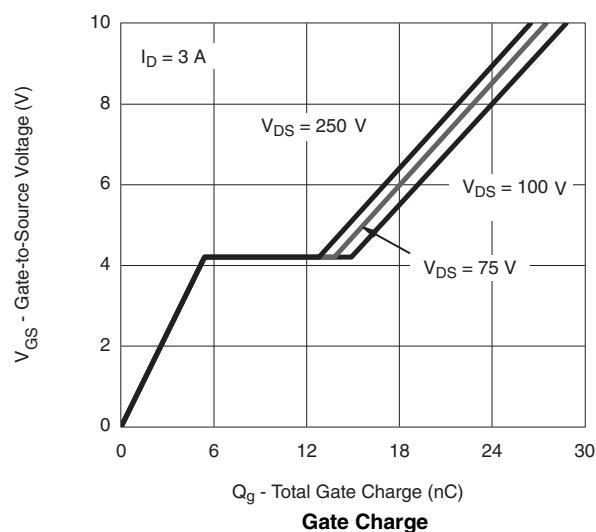
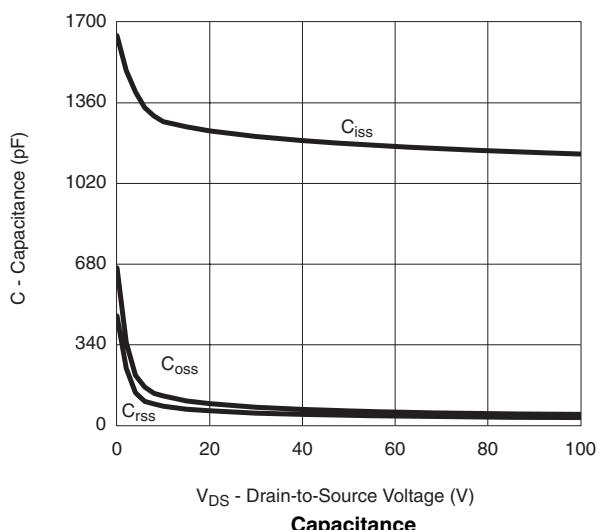
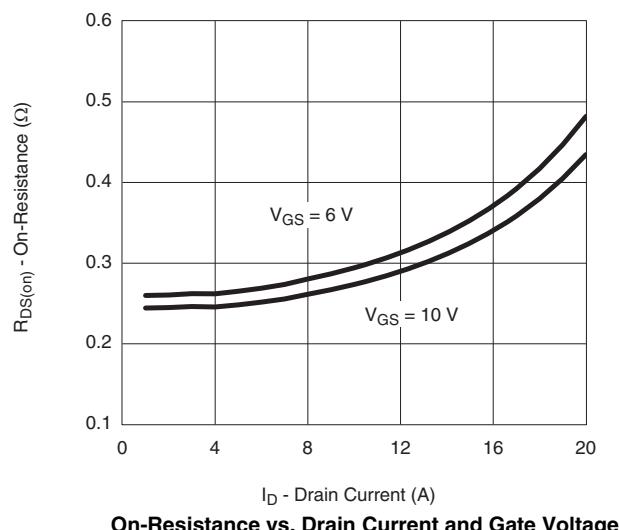
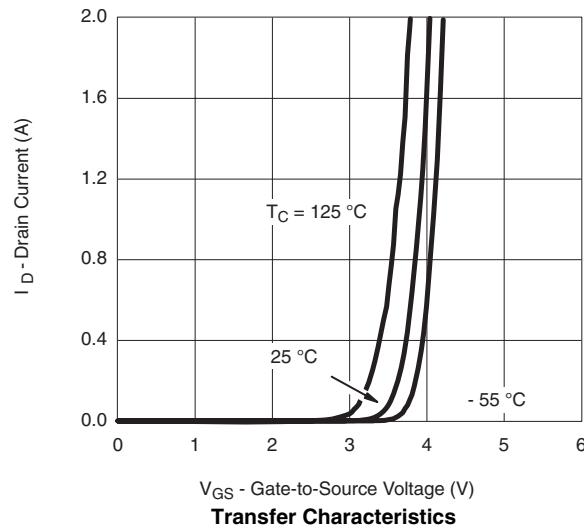
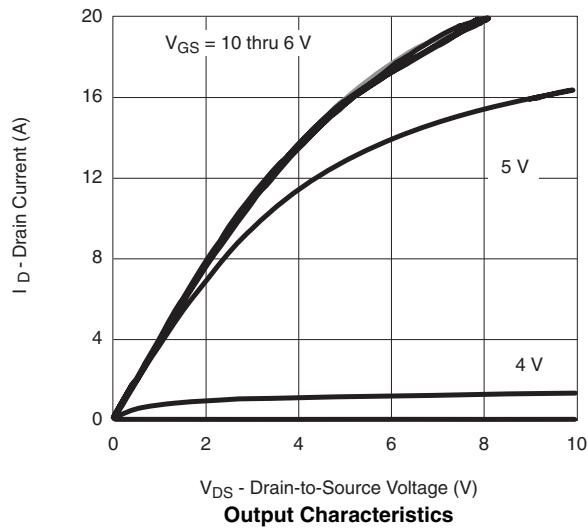
SPECIFICATIONS $T_J = 25 \text{ }^{\circ}\text{C}$, unless otherwise noted

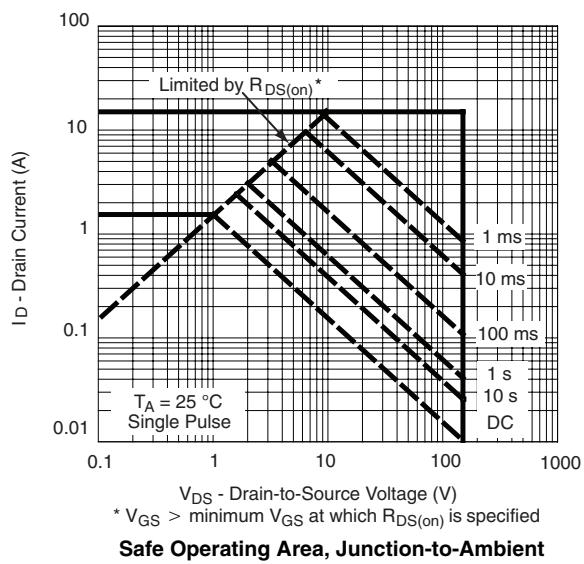
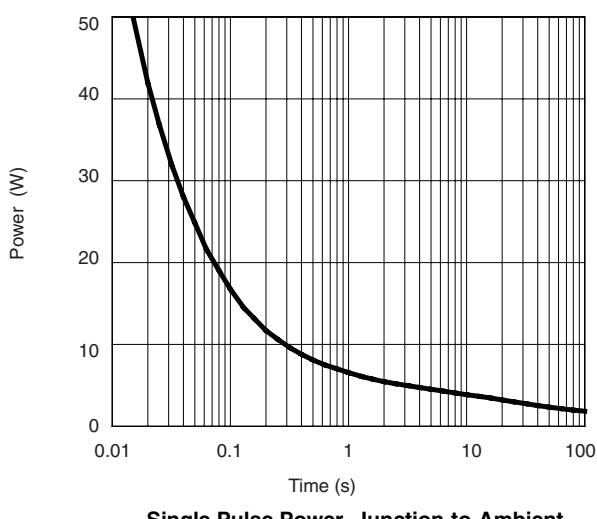
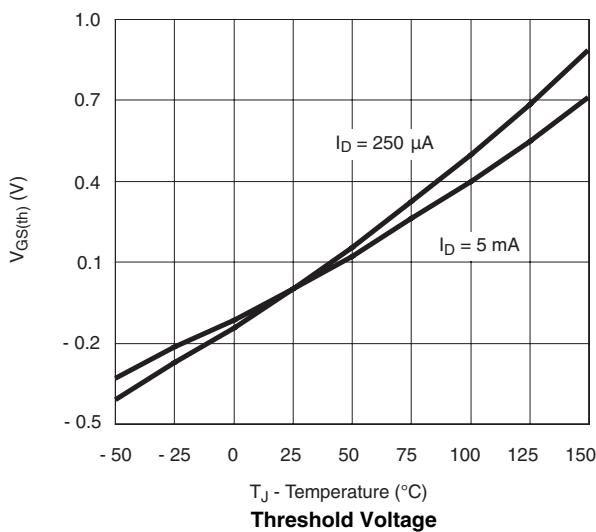
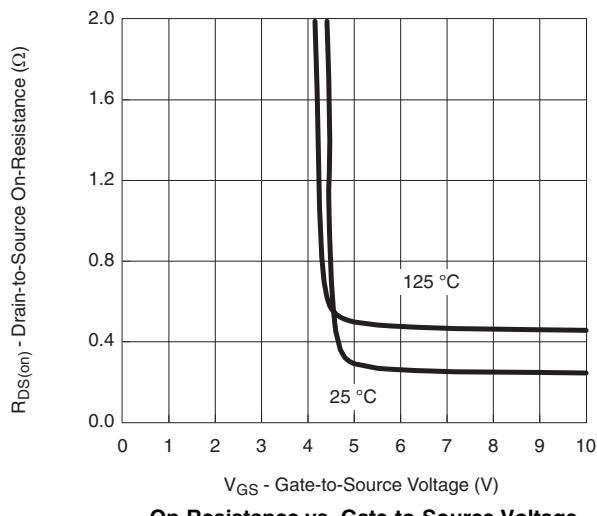
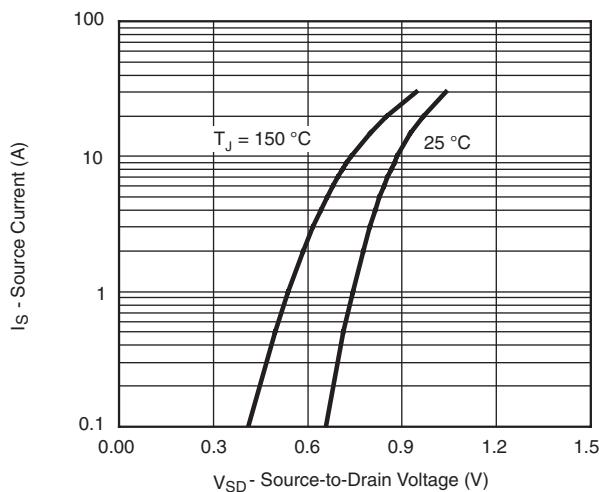
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-150			V	
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250 \mu\text{A}$		-165		mV/°C	
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			-6.6			
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	-2		-4	V	
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -150 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μA	
		$V_{DS} = -150 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ }^{\circ}\text{C}$			-10		
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \geq -5 \text{ V}, V_{GS} = -10 \text{ V}$	-8			A	
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = -10 \text{ V}, I_D = -4 \text{ A}$		0.245	0.295	Ω	
		$V_{GS} = -6 \text{ V}, I_D = -3 \text{ A}$		0.260	0.315		
Forward Transconductance ^a	g_{fs}	$V_{DS} = -15 \text{ V}, I_D = 4 \text{ A}$		12		S	
Dynamic^b							
Input Capacitance	C_{iss}	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1190		pF	
Output Capacitance	C_{oss}			61			
Reverse Transfer Capacitance	C_{rss}			42			
Total Gate Charge	Q_g	$V_{DS} = -75 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3 \text{ A}$		27.5	42	nC	
Gate-Source Charge	Q_{gs}			23.2	35		
Gate-Drain Charge	Q_{gd}			5.4			
Gate Resistance	R_g			8.4			
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -75 \text{ V}, R_L = 25 \Omega$ $I_D \equiv -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_g = 1 \Omega$		6.1	9.2	Ω	
Rise Time	t_r			20	30	ns	
Turn-Off Delay Time	$t_{d(\text{off})}$			95	145		
Fall Time	t_f			38	60		
Turn-On Delay Time	$t_{d(\text{on})}$			34	51		
Rise Time	t_r			11	18		
Turn-Off Delay Time	$t_{d(\text{off})}$			28	42		
Fall Time	t_f			52	78		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	$T_C = 25 \text{ }^{\circ}\text{C}$			-13	A	
Pulse Diode Forward Current ^a	I_{SM}				-15		
Body Diode Voltage	V_{SD}	$I_S = -3 \text{ A}$			-0.8	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -4 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25 \text{ }^{\circ}\text{C}$			65	90	ns
Body Diode Reverse Recovery Charge	Q_{rr}				180	270	nC
Reverse Recovery Fall Time	t_a				45		ns
Reverse Recovery Rise Time	t_b				20		

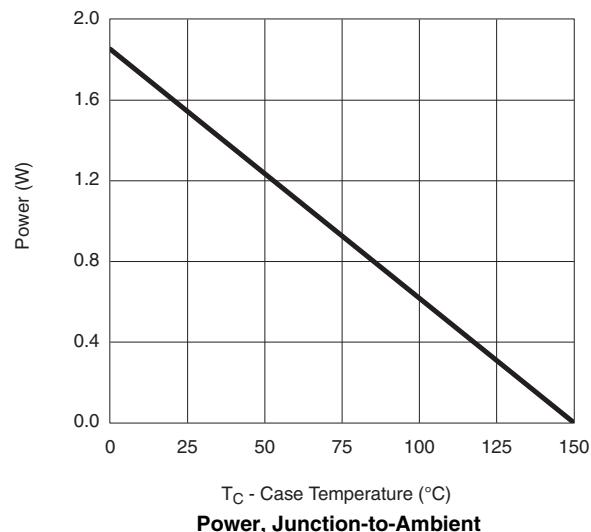
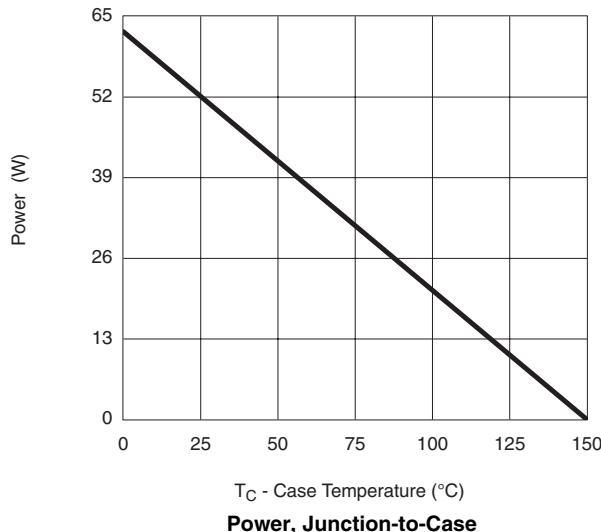
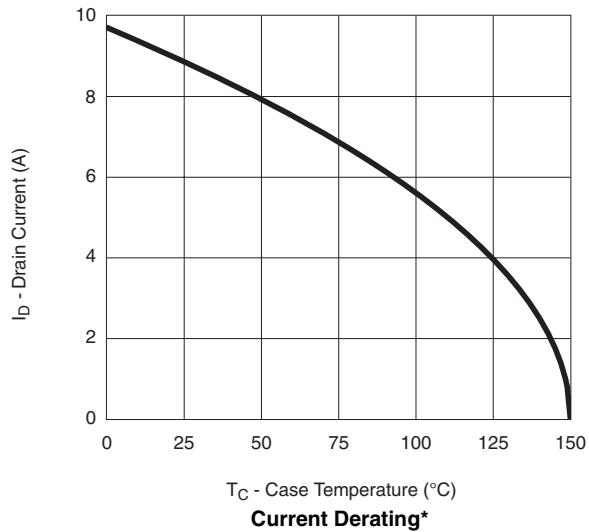
Notes:

- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2 \%$.
b. Guaranteed by design, not subject to production testing.

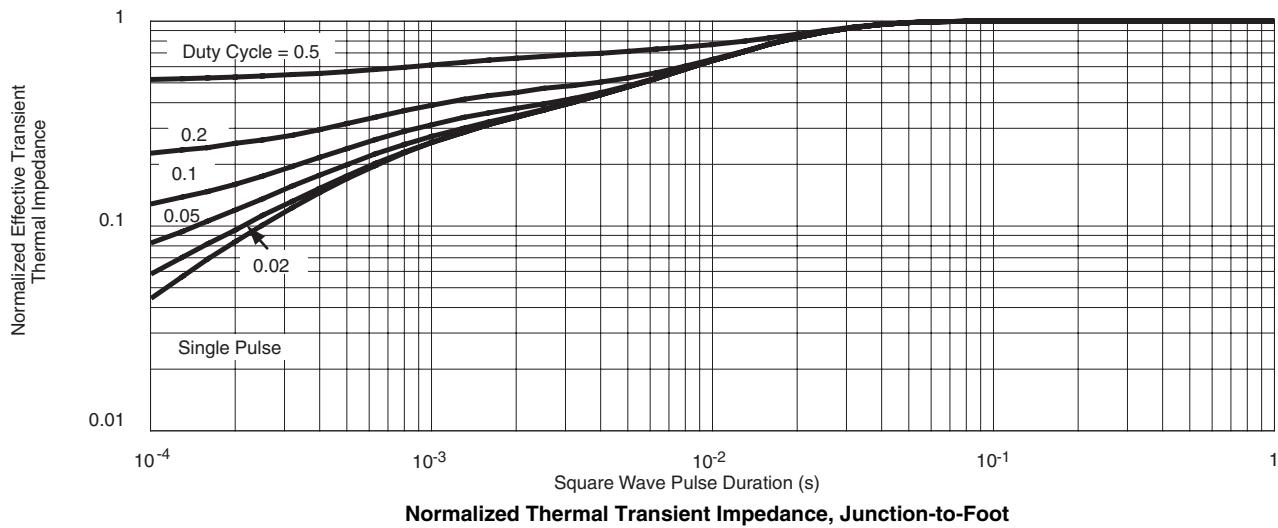
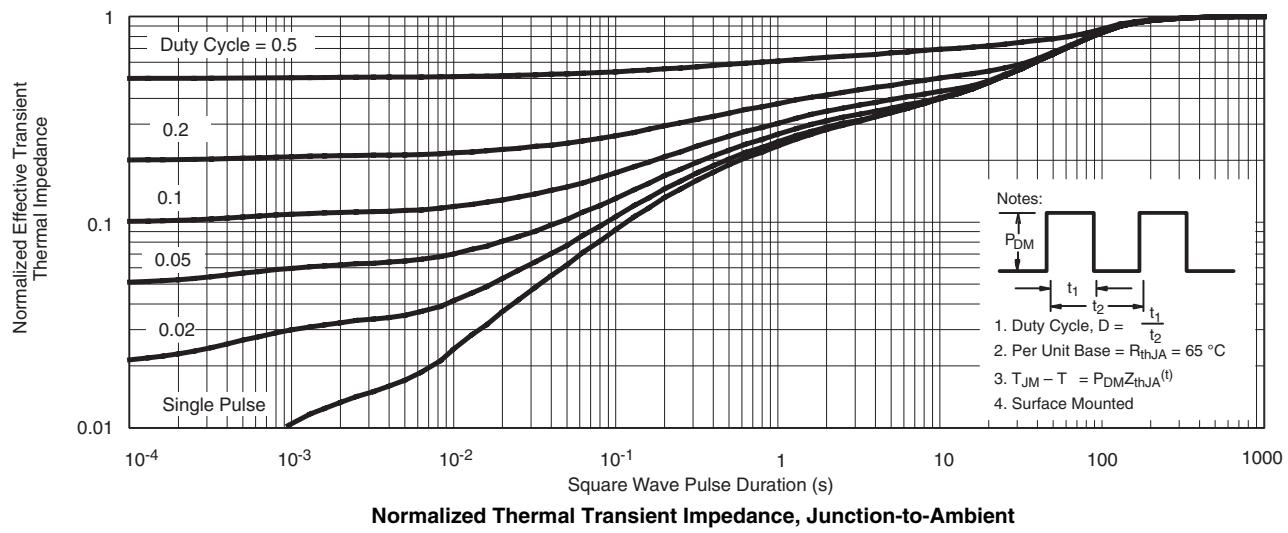
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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* The power dissipation PD is based on T_{J(max)} = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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